





CSD18511KCS

SLPS548A - JULY 2017 - REVISED MARCH 2024

CSD18511KCS 40V N-Channel NexFET[™] Power MOSFET

1 Features

Texas

- Low Q_a and Q_{ad}
- Low R_{DS(ON)}
- Low-thermal resistance

INSTRUMENTS

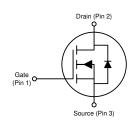
- Avalanche rated •
- Lead-free terminal plating
- · RoHS compliant
- Halogen free
- TO-220 plastic package ٠

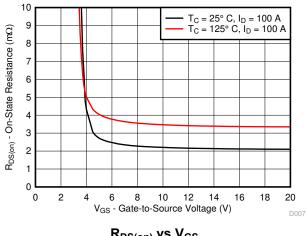
2 Applications

- Secondary side synchronous rectifier •
- Motor control •

3 Description

This 40V, 2.1mΩ, TO-220 NexFET[™] power MOSFET is designed to minimize losses in power conversion applications.





R_{DS(on)} vs V_{GS}

Product Summary								
T _A = 25°	°C	TYPICAL VA	UNIT					
V _{DS}	Drain-to-Source Voltage 40							
Qg	Gate Charge Total (10V)	63.9	nC					
Q _{gd}	Gate Charge Gate-to-Drain	9.7	nC					
R _{DS(on)}	Drain-to-Source On-Resistance	V _{GS} = 4.5V	3.2	mΩ				
		V _{GS} = 10V 2.1		11112				
V _{GS(th)}	Threshold Voltage	1.8	V					

Device Information⁽¹⁾

DEVICE	MEDIA	QTY	PACKAGE	SHIP						
CSD18511KCS	Tube	50	TO-220 Plastic Package	Tube						

For all available packages, see the orderable addendum at (1) the end of the data sheet.

Absolute Maximum Ratings

T _A = 2	5°C	VALUE	UNIT	
V _{DS}	Drain-to-Source Voltage	40	V	
V _{GS}	Gate-to-Source Voltage	±20	V	
	Continuous Drain Current (Package Limited)	110		
I _D	Continuous Drain Current (Silicon Limited), $T_C = 25^{\circ}C$	194	A	
	Continuous Drain Current (Silicon Limited), $T_{C} = 100^{\circ}C$	137		
I _{DM}	Pulsed Drain Current ⁽¹⁾	400	А	
PD	Power Dissipation	188	W	
T _J , T _{stg}	Operating Junction, Storage Temperature	-55 to 175	°C	
E _{AS}	Avalanche Energy, Single Pulse I _D = 56A, L = 0.1mH, R _G = 25Ω	156	mJ	

⁽¹⁾ Max $R_{\theta JC}$ = 0.8°C/W, pulse duration \leq 100µs, duty cycle \leq 1%.

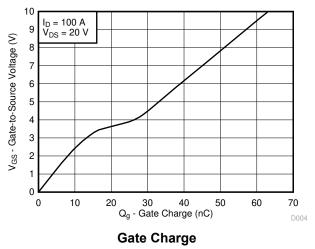




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4 Specifications

4.1 Electrical Characteristics

 $T_A = 25^{\circ}C$ (unless otherwise stated)

	PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
STATIC	CHARACTERISTICS			I	
BV _{DSS}	Drain-to-source voltage	V _{GS} = 0V, I _D = 250µA	40		V
I _{DSS}	Drain-to-source leakage current	V _{GS} = 0V, V _{DS} = 32V		1	μA
I _{GSS}	Gate-to-source leakage current	V _{DS} = 0V, V _{GS} = 20V		100	nA
V _{GS(th)}	Gate-to-source threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1.5 1.8	2.4	V
П	Drain to course on registeres	V _{GS} = 4.5V, I _D = 100A	3.2	4.2	
R _{DS(on)}	Drain-to-source on-resistance	V _{GS} = 10V, I _D = 100A	2.1	2.6	mΩ
g _{fs}	Transconductance	V _{DS} = 4V, I _D = 100A	249		S
DYNAM	IC CHARACTERISTICS			I	
C _{iss}	Input capacitance		4570	5940	pF
C _{oss}	Output capacitance	V _{GS} = 0V, V _{DS} = 20V, <i>f</i> = 1MHz	454	591	pF
C _{rss}	Reverse transfer capacitance		235	306	pF
R _G	Series gate resistance		0.9	1.8	Ω
Qg	Gate charge total (4.5V)		31		nC
Qg	Gate charge total (10V)		64		nC
Q _{gd}	Gate charge gate-to-drain	V _{DS} = 20V, I _D = 100A	9.7		nC
Q _{gs}	Gate charge gate-to-source		17.9		nC
Q _{g(th)}	Gate charge at V _{th}		7.4		nC
Q _{oss}	Output charge	V _{DS} = 20V, V _{GS} = 0V	20.7		nC
t _{d(on)}	Turnon delay time		8		ns
t _r	Rise time	V _{DS} = 20V, V _{GS} = 10V,	6		ns
t _{d(off)}	Turnoff delay time	$I_{DS} = 100A, R_G = 0\Omega$	17		ns
t _f	Fall time		3		ns
DIODE	CHARACTERISTICS			I	
V_{SD}	Diode forward voltage	I _{SD} = 100A, V _{GS} = 0V	0.9	1.0	V
Q _{rr}	Reverse recovery charge	V _{DS} = 20V, I _F = 100A,	62		nC
t _{rr}	Reverse recovery time	di/dt = 300A/µs	31		ns

4.2 Thermal Information

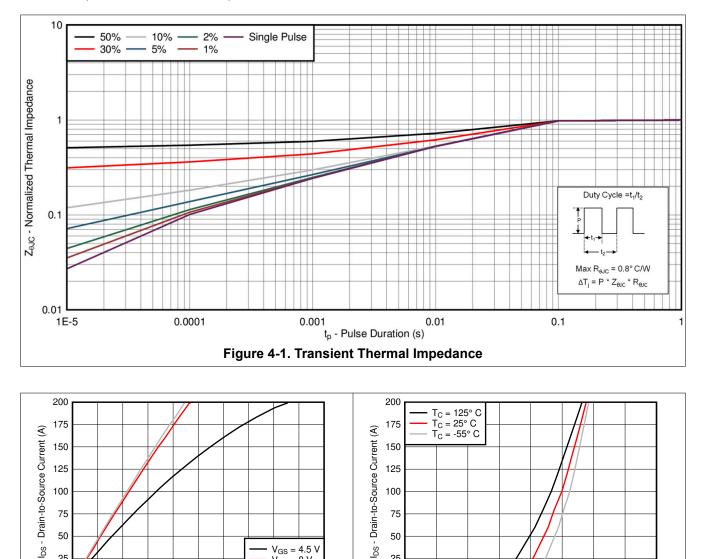
 $T_A = 25^{\circ}C$ (unless otherwise stated)

	THERMAL METRIC	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction-to-case thermal resistance			0.8	°C/W
$R_{\theta JA}$	Junction-to-ambient thermal resistance			62	°C/W



4.3 Typical MOSFET Characteristics

 $T_A = 25^{\circ}C$ (unless otherwise stated)



75

50

25

0

1

1.5

2

V_{GS} -

 $V_{GS} = 4.5 V$

0.9 1

D002

 $V_{GS} = 8 V$ $V_{GS} = 10 V$

0.8

0.2 0.3 0.4 0.5 0.6 0.7 0 V_{DS} - Drain-to-Source Voltage (V)

Figure 4-2. Saturation Characteristics

2.5 3 3.5 4 Gate-to-Source Voltage (V)

 $V_{DS} = 5V$ Figure 4-3. Transfer Characteristics

4

4.5

5

75

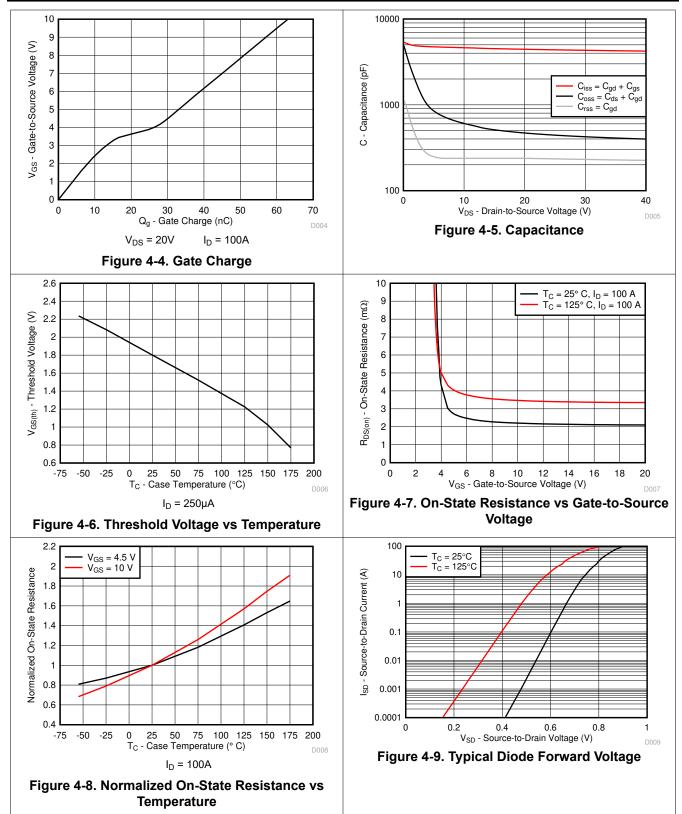
50

25

0

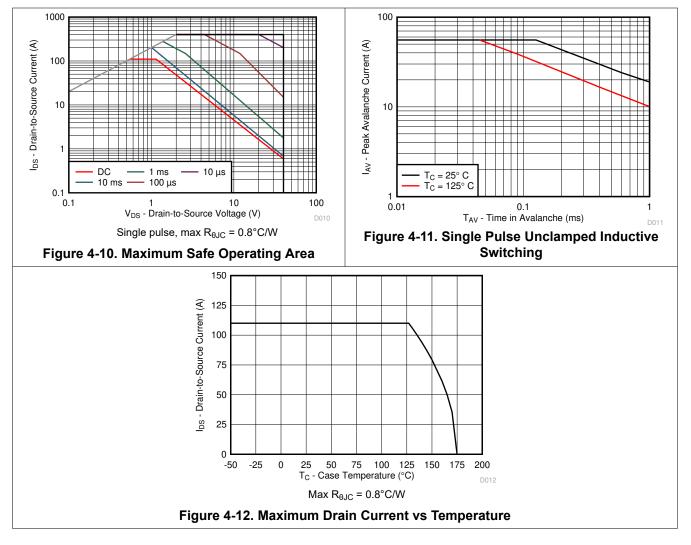
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5 Device and Documentation Support

5.1 Third-Party Products Disclaimer

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To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

5.3 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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5.4 Trademarks

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5.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

5.6 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

6 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision * (July 2017) to Revision A (March 2024)

Page



7 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
						(4)	(5)		
CSD18511KCS	Active	Production	TO-220 (KCS) 3	50 TUBE	ROHS Exempt	SN	N/A for Pkg Type	-55 to 175	CSD18511KCS
CSD18511KCS.B	Active	Production	TO-220 (KCS) 3	50 TUBE	ROHS Exempt	SN	N/A for Pkg Type	-55 to 175	CSD18511KCS

⁽¹⁾ **Status:** For more details on status, see our product life cycle.

⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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TEXAS INSTRUMENTS

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23-May-2025

TUBE



- B - Alignment groove width

*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
CSD18511KCS	KCS	TO-220	3	50	532	34.1	700	9.6
CSD18511KCS.B	KCS	TO-220	3	50	532	34.1	700	9.6

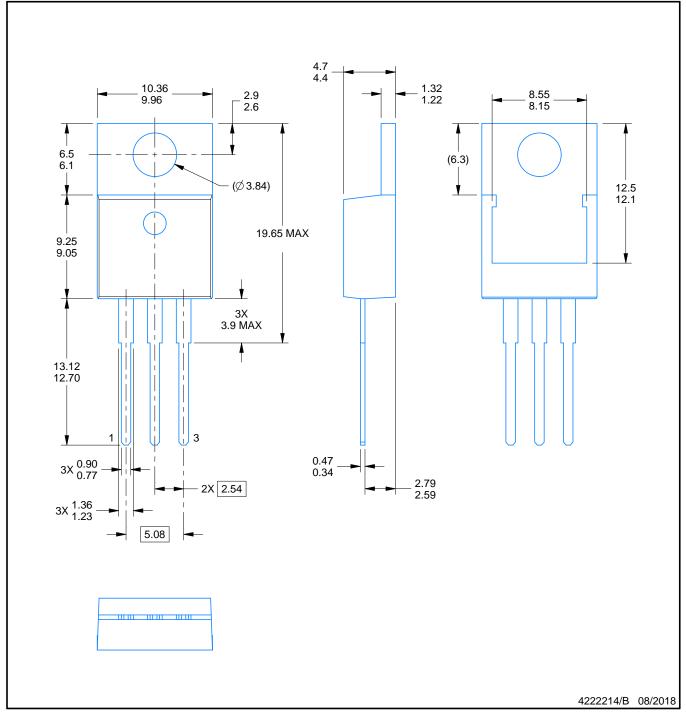
KCS0003B



PACKAGE OUTLINE

TO-220 - 19.65 mm max height

TO-220



NOTES:

- 1. Dimensions are in millimeters. Any dimension in brackets or parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
 This drawing is subject to change without notice.
 Reference JEDEC registration TO-220.

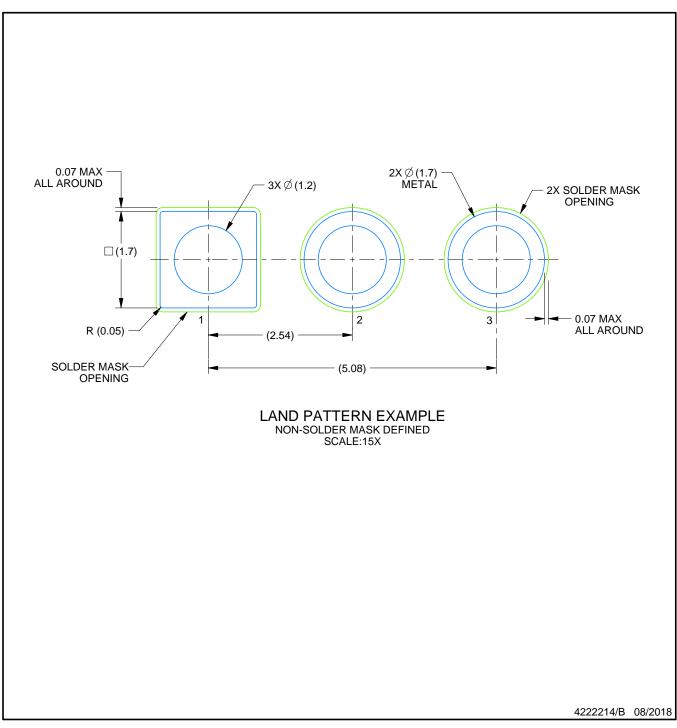


KCS0003B

EXAMPLE BOARD LAYOUT

TO-220 - 19.65 mm max height

TO-220





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